Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/689,629	KIM ET AL.	_
Examiner	Art Unit	
George A. Goudreau	1763	

SEARCHED					
Class	Subclass	Date	Examiner		
438	41	12-05	( GAG		
438	60		GAG		
438	75		GAG		
438	694		GAG		
438	745		GAG		
438	752	$\Delta$	GAG <sub>.</sub>		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STN: CAPLUS, JAPIO, INSPEC, USPAT2	12-651	GAG	
EAST: USPB, USPT, WPID,JPO	<b>*</b>	GAG	
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